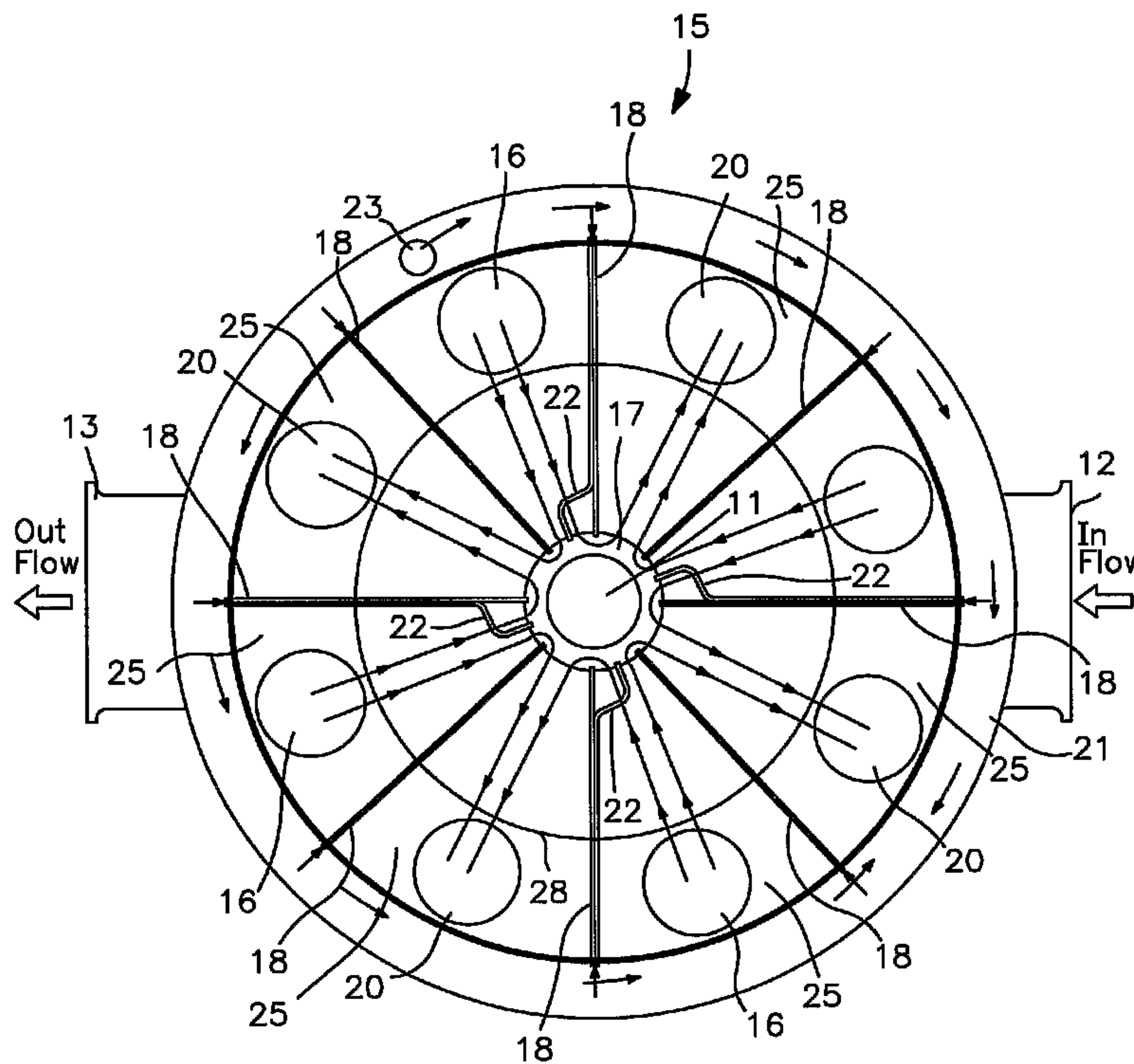




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 (54) Title: A REACTION CHAMBER



(57) **Abrégé/Abstract:**

A novel reaction chamber is described for the treatment of gases which either have a noxious odor or include toxic elements. The chamber is for treatment of the gases with energetic electrons and uses an extended electron source in the center of a chamber volume which creates electrons that move out of the source and radially into the chamber. The gases are flowed into the area of the source and away from the source as to result in uniform and efficient exposure of the flowing gases.

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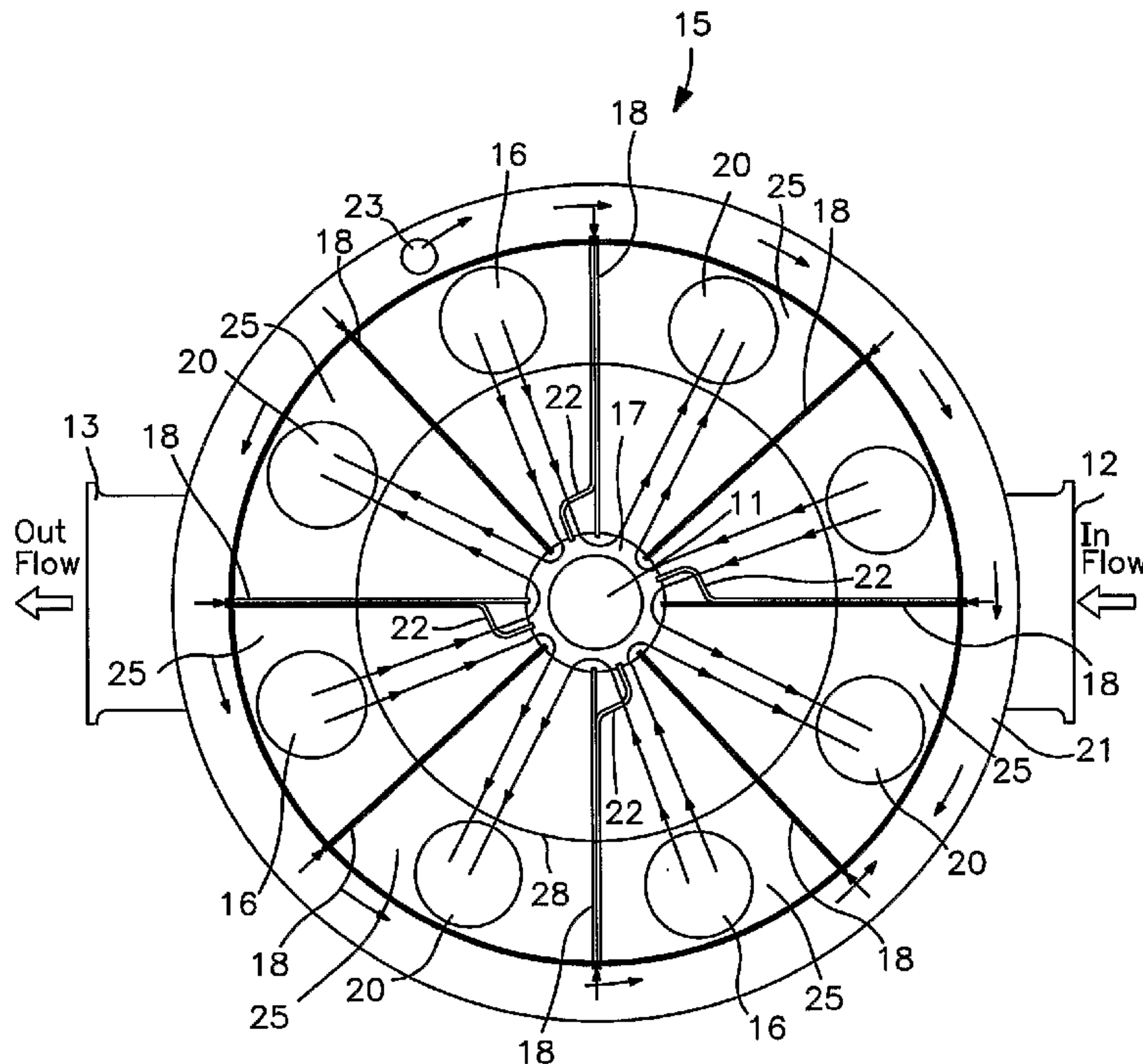
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(54) Title: A REACTION CHAMBER



(57) Abstract: A novel reaction chamber is described for the treatment of gases which either have a noxious odor or include toxic elements. The chamber is for treatment of the gases with energetic electrons and uses an extended electron source in the center of a chamber volume which creates electrons that move out of the source and radially into the chamber. The gases are flowed into the area of the source and away from the source as to result in uniform and efficient exposure of the flowing gases.

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A REACTION CHAMBER

1

2

FIELD OF THE INVENTION

This invention has to do with reaction chambers or reaction volumes for efficient energy transfer to gases. In particular, the objective is to optimize the exposure of contaminated gases to energetic electrons generated by a symmetrical electron beam source shaped as an extended cylinder.

8

BACKGROUND OF THE INVENTION

Energetic electrons are used today to neutralize toxic gases and to reduce noxious odors. Although some interest has been expressed in the shape of the chamber in which such treatments occur, in fact to date, the emphasis has not been one of great interest in optimizing chambers for efficient treatment. Various patents exist in this field and some do discuss the reaction chambers. For example in U.S. Patent No. 5,319,211, a detoxification plenum or tank is illustrated in which electrons attack gases moving through. Also referred to in that patent are U.S. Patent Nos. 4,507,265; 5,015,443; 4,569,642; and 4,915,916, patents all dealing with the reduction of toxic flue gases generally found in power plants where massive structures are used for treatment of effluent stack gases. These gases are generally SO_x and NO_x or organics with toxics present. A similar plenum to the one illustrated in U.S. Patent No. 5,319,211 is also shown in U.S. Patent 5,357,291. The chamber in this latter patent is illustrated as transportable and is discussed with supplemental treatment stations to clean fluids primarily gaseous in nature. All of these are generally large and cumbersome and none were created for efficient transfer of energetic electrons. Accordingly, neither the environmental nature of the gas nor the smell of the gas is improved as much as might be done if an improved transfer of energetic electrons could be achieved. Since the technique of treating gases with energetic electrons is in early stages of development, only limited interest has been shown in shaping chambers to achieve efficient radiation of gas flows subjected to treatment or to create chambers of small sizes as to enable systems to fit into more enclosed areas as to simplify the fit of systems within enclosures.

33

1 A different structure, which can be considerably smaller than those
2 illustrated in the patents that have been discussed, is illustrated and described in
3 U.S. Patent No. 5,378,898. In this case, the chamber was designed to receive
4 electrons spewed out of the end of an electron source which although operative
5 for the system shown may not be the best combination of generator and chamber
6 for efficient treatment of toxic or noxious smelling gases.

7

8 **Summary of the Invention**

9 This invention is concerned with the optimization of equipment and
10 processes to expose contaminated gas flows to energetic electrons generated by
11 an electron beam source shaped like an extended cylinder. The source which
12 has been developed for this application may comprise a vacuum tube of the type
13 described in pending U.S. Patent Application Serial No. 10/822,890, the
14 disclosure of which is incorporated herein by reference. This device has the
15 unique quality of emitting electrons circumferentially. The emitted electrons are
16 caused to interact and/or bombard carrier gases, typically air, that contain or carry
17 undesirable contaminating compounds. The objective is to convert the
18 contaminant compounds into compounds that are more environmentally
19 acceptable from the point of view of regulations, health and/or smell. The carrier
20 gas with contaminants is flowed through a conduit and directed into a chamber
21 which may be called a reaction chamber or a reaction chamber volume. Electrons
22 produced within a vacuum are accelerated by an applied voltage and are caused
23 to pass through a thin window of the vacuum unit into the reaction volume where
24 they interact through electromagnetic processes with the compounds in the
25 flowing gas. This form of interaction produces a chain of chemical reactions
26 meant to reduce undesirable compounds to more acceptable compounds or bad
27 smells to acceptable ones.

28

29 In order to effectively treat a fluid flow, it is important to design the reaction
30 chamber such that the available electron energy is transferred as efficiently as
31 possible to the incoming atoms in order to initiate chemical reactions leading to
32 the optimum level of conversion in time and quantity of the contaminating
33 compounds.

34

1 Electrons have a relatively short range in gases, depositing a large amount
2 of their energy more or less uniformly within a short distance, then losing the
3 balance of energy in a short distance thereafter. Because of this, it is important
4 that the gas to be treated flows through that volume of a reaction vessel where
5 most of the energy of the electrons is deposited. Thus an objective is to deposit
6 the energy per unit volume as uniformly as possible into each fraction of the
7 moving gas. To achieve this objective, the gas must be forced to flow through the
8 region of high electron intensity. As this occurs electrons collide with molecules
9 and alter the compounds in the gas to form radicals that initiate reactions that will
10 reduce the contaminants in the gases themselves. This is achieved in large
11 measure through the design of the reaction chamber of this invention.

12

13 Other factors that enter into the reaction volume design are the need for
14 radiation shielding from X-rays produced both by the electron source itself and in
15 the reaction volume structure, and to minimize the pressure drop and dynamic
16 pressure of the gas flowing through the chamber. Dimensions of air flow paths
17 within the reaction volume need to be designed to accommodate the flow to
18 minimize flow resistance and dynamic pressure of the flowing gas. These
19 considerations also impact the size of blowers or compressors used to force gas
20 through the reaction volume at the required rate. One of the objectives of this
21 design is to reduce flow resistance through the reaction volume to less than that
22 presented by connecting input and output piping. Thus typical gas fluid dynamic
23 calculations may be applied to determine the dimensions required to meet these
24 criteria.

25

26 **Brief Description of the Drawings**

27 Figure 1 is a schematic drawing of an embodiment of a top view of a
28 reaction chamber volume in which upper cover is removed.

29 Figure 2 is cutaway schematic view of an internal section of the reaction
30 chamber.

31 Figure 3 is a cutaway schematic of another internal section of the reaction
32 chamber.

33

34

1 Detailed Description of the Invention

2 The geometry of the electron source is a major factor in how the chamber
3 should be designed in order to accomplish the objectives of efficient treatment of
4 a flowing gas. In this instance, a cylindrical source is used since it appears to
5 offer the greatest possibility of a highly efficient treatment system as will be further
6 described herein. The reaction chamber is optimized for an extended cylindrical
7 source as shown in Figure 1 or for a cylindrical source like that discussed in
8 Figure 1. The source may be segmented around its periphery, either into a single
9 segment of any angular extension, or into symmetrically or asymmetrically
10 arranged segments of any chosen angular segment or segments. Such a source
11 is fully described in pending application Serial No. 10/822,890 incorporated herein
12 by reference above. The preferred source for this invention is one that provides
13 an output around its entire periphery.

14

15 For a cylindrical source of electrons, the preferred approach is to cause
16 maximum energy transfer or power transfer to the incoming gas by directing the
17 incoming gas directly, radially, toward the source around the 360 degree
18 circumference of the source. The gas, after flowing to the source, is then diverted
19 to an adjacent radially located chamber to carry the flow out of the reaction
20 volume. This approach is shown and described in connection with the Figures
21 that follow.

22

23 The approach chosen in the embodiment illustrated is to direct the flow
24 radially inward, turn it around and flow it radially outward on a separate path. This
25 is accomplished by dividing the cylindrical volume around the cylindrical source
26 into pie-shaped segments, flowing gas inward in one pie shaped section, turning
27 the flow in that section at the source and flowing the gas to the next section and
28 then outwardly away from the center. Controlling the process gas flow in this
29 manner exposes the flowing gas being fed to the chamber for treatment to the
30 entire space distribution of the beam.

31

32 Referring now to Figure 1, a reaction chamber 15 is illustrated (with the
33 cover removed) and includes a central source for energetic electrons which may
34 comprise an electron beam source 11 such as a vacuum tube to generate

1 electron beams disclosed and described in pending patent application Serial No.
2 10/822,890 or may comprise other sources capable of emitting energetic
3 electrons in a radial pattern from an extended cylindrical central element or central
4 area or volume in chamber 15. This for example in a small unit could comprise a
5 corona generator such as an elongated wire to which a high voltage is applied.
6 The materials to be treated which generally will be a fluidic flow of gaseous
7 compounds are fed into the reaction volume through conduit 12 and after
8 treatment within the reaction volume exit from chamber 15 through conduit 13.
9 Connected to the reaction volume are input openings 16 to convey the incoming
10 gases for treatment into a pie shaped segment of the reaction volume in an
11 effective zone of the charged particles. These openings 16 are connected to the
12 input conduit 12 through plenum 26 (shown in Figure 2) so that an inflow of gas to
13 be treated travels into the input conduit 12, through plenums 26 and out of
14 openings 16 into the reaction volume for treatment purposes. Gases from
15 openings 16 are directed to the center area where electron source 11 is located.
16 The input flow as it reaches or just about reaches the source is directed into path
17 17 adjacent to and around source 11. The gases move as directed by vanes 18
18 to and against source 11 and then back through an adjacent pie shaped section
19 25 and out through output openings 20. Thus gas flow from the inlet openings 16
20 travels to source 11 and then to outlet openings 20 on either side of the subject
21 inlet pie section 25. Openings 20, through which the outflowing gases travel from
22 the reaction volume, in turn, are connected to output conduit 13 from which the
23 gases leave reaction chamber 15.

24

25 Contaminated air flowing in and out through plenum connecting tubes to
26 openings 16 and/or 20, pass through a perforated cylinder 28 on the path toward
27 and away from the electron source. This perforated wall is for the purpose of
28 smoothing the air flow and uniformly distributing air during its path to and from the
29 electron source.

30

31 Along the outer wall of the circumference of the illustrated chamber 15, is
32 coaxially positioned passageway 21, a separate, narrow plenum, not part of the
33 chamber volume where gases are treated. Clean air is fed to this passageway 21
34 through input tube 23, which in this instance feeds uncontaminated air from a

1 blower or compressor (not shown). Air from this passageway 21 is in turn fed
2 down small tubes 27 generally in the center of, and on the surface of, vanes 18
3 and the flowing air feeds to and against source 11 which maintains the surface of
4 source 11 clean of contaminants. At the central area of the reaction volume, lips
5 22 are formed on tubes 27 positioned on or in vanes 18 which direct the flowing
6 gas (from the passageway 21) to create a controlled thin layer of uncontaminated
7 air over the beam exit windows. This air prevents contaminants that might
8 produce a corrosive compound from attacking the beam window or a compound
9 that might cause deposits on the beam window as to reduce the effects of the
10 electron beam flow through the window.

11

12 Source 11 releases electrons around its circumference and the gases that
13 travel through pathway 17 are exposed at that stage to the flow of the most
14 energetic of the output electrons. The gases that pass into the pie shaped
15 sections 25 of the chamber and pass out through similar pie shaped segments 25
16 are also exposed in passing to the entire space distribution of the beam. In this
17 way the gases travelling through the reaction volume are uniformly exposed to the
18 electrons generated by source 11.

19

20 Flow control devices such as vanes, perforated planes, balance bars, or
21 splitter plates may be employed to ensure a uniform distribution of gas flow within
22 the reaction volume. Vanes are illustrated in this Figure.

23

24 The diameter of the reaction chamber 15, or more accurately the
25 length of vanes 18 that define pie shaped segments 25, is controlled and
26 determined by the energy of the electrons emitted from electron source
27 11. That energy determines the electrons' range. In the case of the use
28 of a cylindrical tube as source 11, the high voltage applied to the electron
29 beam tube and window thickness determine the energy of the electrons
30 emitted.

31

1 The output of the tube is controlled by controlling the current
2 emitted from the cathode and can be raised or lowered within its design
3 limitations. This increases or decreases the dose delivered to the flowing
4 gas. Dose applied depends on the power in the beam injected into the
5 flowing gas and the flow rate of the gas through the reaction chamber.

6

7 The reaction chamber is designed to handle a maximum flow rate
8 with the minimum of flow resistance through the system. In this
9 embodiment, the upper limit of flow rate was designed to be 1200 cfm
10 (2,000 m³/hour). The chamber in this case has a diameter of
11 approximately 3 to 4 feet and an internal volume where gas is treated of
12 approximately 13,000 cubic inches and an overall internal volume including
13 input and output conduits and other connecting plenums in the system of
14 approximately 28 cubic feet. System 15 also has a total weight with
15 shielding (discussed below), of approximately 3000 pounds. Higher flow
16 rates are possible but the power of a blower to drive the air stream
17 through the system would have to increase non-linearly as one increases
18 the flow rate. Alternatively, the entire system can be increased in size
19 and capacity using the instant design as a base or in the case of a lower
20 usage rate as for example where the chamber is used on the output vent
21 of instrumentation using toxic materials, the design may be used to create
22 a smaller system.

23

24 In the event that the contaminated gases require more dose than is
25 available from the electron beam tube or source 11 operating at maximum
26 output at the required flow rate of the air stream, additional systems may
27 be included in the treatment facility and the contaminated gases would
28 then be shared between systems. Alternatively, source can be
29 constructed to generate a greater output. However, since one is dealing

1 with in one instance vacuum tubes feeding electrons through a window,
2 there is value to avoid attempting too high an output from such a source
3 since one will encounter problems with the windows, cathodes, power
4 supplies, etc. as one increases size and output requirements. In general a
5 source with an output of several kilowatts of beam power is illustrated in
6 the configurations discussed in these applications.

7

8 In Figure 2 there is illustrated the reaction chamber 15 in a cutaway
9 view that shows a single output plenum 26 connected between input
10 opening 16 and input conduit 12. This plenum extends through output
11 conduit 13. Also shown is the connection between opening 20 and output
12 conduit 13. Although only a single input plenum 26 is shown, it will be
13 understood from the illustration in Figure 1, that a plurality (4 in Figure 1)
14 of these connecting plenums exist between the reaction volume and the
15 input conduit 12 as to provide a flow path to each of the input openings
16 16 shown in every other section of the reaction volume of Figure 1. In a
17 like sense although only a single opening is shown between the output
18 conduit and the volume of the reaction chamber, four holes with
19 connecting tubes are strategically placed throughout the volume matching
20 openings 20 in Figure 1 connecting the volume of the chamber volume to
21 the output conduit. A vane 18 is also shown in this Figure.

22

23 Referring now to Figure 3, there is illustrated another cut away view
24 that is intended to clarify aspects of chamber 15 shown and discussed in
25 connection with Figures 1 and 2. Two pie shaped sections 25 can be seen
26 in this Figure. Passageway 21 is seen extending around the outer rim area
27 of the reaction chamber. Vanes 18 extend from the inner wall of outer
28 passageway 21 to the central area near where the source or tube 11 is
29 positioned. Along the surface of vanes 18 are a number of small tubes 27

1 that transport clean air used to prevent or reduce the deposit of material on
2 the electron emitter windows or surface. In some applications of electron beam
3 destruction, the incoming gas stream may also contain particulate matter that can
4 become deposited on the windows of the electron beam emitting device. Such
5 deposits, if built up sufficiently, would cause significant energy loss of the
6 emerging electrons, thereby decreasing the electron energy and power available
7 for treatment of the waste stream emissions. Further, if the contents are corrosive
8 to the beam windows, the window material could become eroded, eventually
9 causing pinholes leading to vacuum loss within the electron emitter device.

10
11 Tubes 27 comprise a series fine tubes as sources of clean air attached to
12 vanes 18 of the pie sections 25 with output ends directed toward the surface of
13 the emitter or source 11. The air flowing out of tubes 27 is flowed toward the
14 surface of the source or in the case of vacuum tube with emitter windows to the
15 surface of the emitter windows. Tubes 27 are located so that the air from the
16 tubes, tends to create an isolating layer of air (an "Air Curtain") over the window
17 surface, and then flows out into the reaction volume or the pie shaped sections 25
18 from which the air is carried out of the reaction chamber through the exit openings
19 20 and then out of the exit conduit 13. Tips 22 can be seen at the ends of the
20 tubes. These act to direct the gases flowing down the pie shaped sections 25
21 toward the adjacent pie shaped section 25 to return to the output openings 20
22 where the treated gases exit from the reaction volume and then exit the reaction
23 chamber 15.

24
25 Air fed through the small tubes is driven by an external blower. The air is
26 directed to flow across the surface of the tube window or windows to form a
27 protective layer that prevents the contaminated air to be treated from flowing to
28 the surface of the windows. The thickness of the protective layer is controlled by
29 the rate of air flowing from the small tubes, and this can be adjusted by blower
30 controls.

31
32 Air from the blower is also directed into passageway 21 through input tube
33 23. Air entering this passageway from the blower flows around the periphery of
34 the entire reaction chamber and into the distal ends of small tubes 27 that open to

1 this passageway. The cross sectional area of the passageway is designed to
2 minimize the pressure drop throughout to assure that air flows uniformly through
3 each of small tubes 27 along all the vanes 18.
4

5 The outside of the reaction chamber walls and the top and the
6 bottom should be shielded with lead. The thickness of the shielding for a
7 particular reaction chamber to bring leakage radiation to below natural
8 background is determinable using a Monte Carlo program. The calculations
9 should take into account the maximum high voltage that accelerates the
10 electrons as well as the maximum beam current. Thus the amount of
11 shielding will depend on the particular reaction chamber and its
12 specifications. In the chamber described in this specification, the shielding
13 thickness varied from 3/8" to 1/2". Thickness in each instance is
14 dependent on energy and the magnitude of the beam intensity. Radiation
15 leakage measurements were used to confirm that using the findings of the
16 Monte Carlo program results in correct amounts of shielding.
17

18 If there is an application that contains corrosive compounds that
19 could attack the internal walls of the reaction chamber, or if acids result
20 from the breakdown of treated compounds (e.g.; compounds containing
21 chlorine upon treatment will contain hydrochloric acid aerosols), either
22 corrosive resistant metals can be used in the fabrication of the reaction
23 chamber, or corrosive resistant coatings can be applied (e.g.; silicon
24 carbide) to the surfaces of the chamber.
25

26 Internal dimensions of the reaction chamber 15 depend on the gas flow
27 rate for the process and the energy of the electron beam. The number of pie
28 shaped sectors, the size of the of the inner and outer plenums, and the geometry
29 of the flow control devices are designed to minimize the pressure loss through the
30 reaction chamber and to provide uniform flow of process gas past the electron

1 beam source. For example, the gas flowing into and out of the pie shaped sectors
2 and through the vertical tubes that connect to the input and output plenums flows
3 at low velocity through a partition of metal perforated with a pattern of holes (28)
4 designed to cause uniform and smooth gas flow toward and away from the
5 electron emitter.

6
7 Other embodiments for introducing the gas to the reaction volume include a
8 circumferential plenum and axial plenums located above and below the reaction
9 volume.

10
11 Although exemplary embodiments of this invention have been shown and
12 described, it will be understood by those skilled in the art that variations of the
13 chamber structure and its operation may be employed depending on the particular
14 application intended and that such structures will follow from the understanding
15 imparted by the equipment illustrated and the discussion of its operation as to
16 facilitate modifications that may be made in the mechanisms of the system and its
17 operation without departing from the scope of the invention as defined in the
18 appended claims.

CLAIMS

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What is claimed is:

1. A reaction chamber comprising
a circular housing enclosing a chamber volume,
an input conduit to feed fluids for treatment into the chamber volume,
an output conduit to feed treated fluids out of said chamber volume,
an extended cylindrical electron source positioned centrally and extending
through the chamber volume,
a first set of passageways between said input conduit to feed incoming fluid
from said input conduit into the reaction chamber volume,
a second set of passageways between said reaction chamber volume and
said output conduit to feed fluids treated within the chamber volume to said
output conduit,
fluid flow paths within said chamber volume to flow incoming fluids from
said first set of passageways to said extended cylindrical electron source
and then away from said source and to said second set of passageways
exposing the fluid to be treated in the chamber volume to energetic
electrons issuing from said cylindrical electron source, and
releasing said treated fluid out said output conduit.
2. The reaction chamber of claim 1 in which the walls, top and base are
shielded with lead to protect against radiation exposure.
3. The reaction chamber of claim 1 in which the reaction chamber volume is
made up of a plurality of pie shaped sections and in which alternate sections are
connected to said first set of passageways and the flow is to said electron source.
4. The reaction chamber of claim 3 and in which pie shaped sections adjacent
to said sections in which connected to said first set of passageways is connected
to said second set of passageways.
5. The reaction chamber of claim 1 in which inner walls of said first set of
passageways include a protective coating to protect said walls against caustic
materials passing therethrough.

1

2 6. The reaction chamber of claim 3 in which there is interposed a perforated
3 wall between the openings of said first set of passageways to said pie shaped
4 sections and said electron source.

5

6 7. The reaction chamber of claim 6 in which the perforated wall also extends
7 between said electron source and the opening in the reaction volume to said
8 second set of passageways to said output conduit.

9

10 8. The reaction chamber in accordance with claim 1 including tubular
11 connections to feed air to said source to form an air curtain across its surface.

12

13 9. The reaction chamber in accordance with claim 8 in which the air is fed to
14 said source through tubes extending along vanes within the reaction chamber
15 volume that define the pie shaped sections therein.

16

17 10. A reaction chamber to expose gases passing therethrough to energetic
18 electrons, comprising

19 an enclosed cylindrical housing defining a reaction chamber volume,

20 partitions defining pie shaped sections within said chamber volume,

21 a centrally positioned extended cylindrical source to release electrons into
22 said volume,

23 input pathways to feed gases for treatment into selected said pie shaped
24 sections and to direct such gases to said centrally positioned cylindrical
25 source where electrons collide with molecules and alter the compounds in
26 the gas to form radicals that initiate reactions,

27 a second gas source to feed gases around the circumference of said
28 cylindrical source,

29 output pathways to feed gases away from said cylindrical source in pie
30 shaped sections adjacent to said pie shaped sections fed by said input
31 paths, and

32 conduits connected to said output pathways as to feed treated gas out of
33 the reaction chamber.

34

1 11. A reaction chamber in accordance with claim 10 in which a perforated wall
2 is positioned in the path of the flow of the gases to and from said cylindrical
3 source.

4
5 12. A reaction chamber in accordance with claim 11 in which said volume is
6 shielded to make said reaction chamber radiation safe.

7
8 13. A method of treating a gas comprising flowing the gas to be treated into a
9 reaction volume, directing the gas toward an extended cylindrical source of
10 electrons in the center of the reaction volume issuing electrons circumferentially
11 from said source, causing the gas to flow along a portion of the surface of said
12 source while in near contact with said source, and flowing the gas away from said
13 source and out of said reaction volume.

14
15 14. A method of treating a gas in accordance with claim 13 in which the said
16 source creates energetic electrons and in which said gas is initially toxic and is
17 treated to make said toxic gas environmentally more acceptable.

18
19 15. A method of treating a gas in accordance with claim 13 in which the said
20 source creates energetic electrons and in which said gas initially has a noxious
21 odor and is treated to improve the social acceptability of the smell of the gas.

22
23 16. A method of treating a gas in accordance with claim 13 including creating
24 an air curtain around said extended cylindrical source protecting said source
25 during treatment of treatable gases in said reaction volume.

26
27 17. A method of treating a gas in accordance with claim 13 in which the flowing
28 gas flowing to and from said extended cylindrical source passes through a porous
29 wall in its path smoothing the gas flow.

30

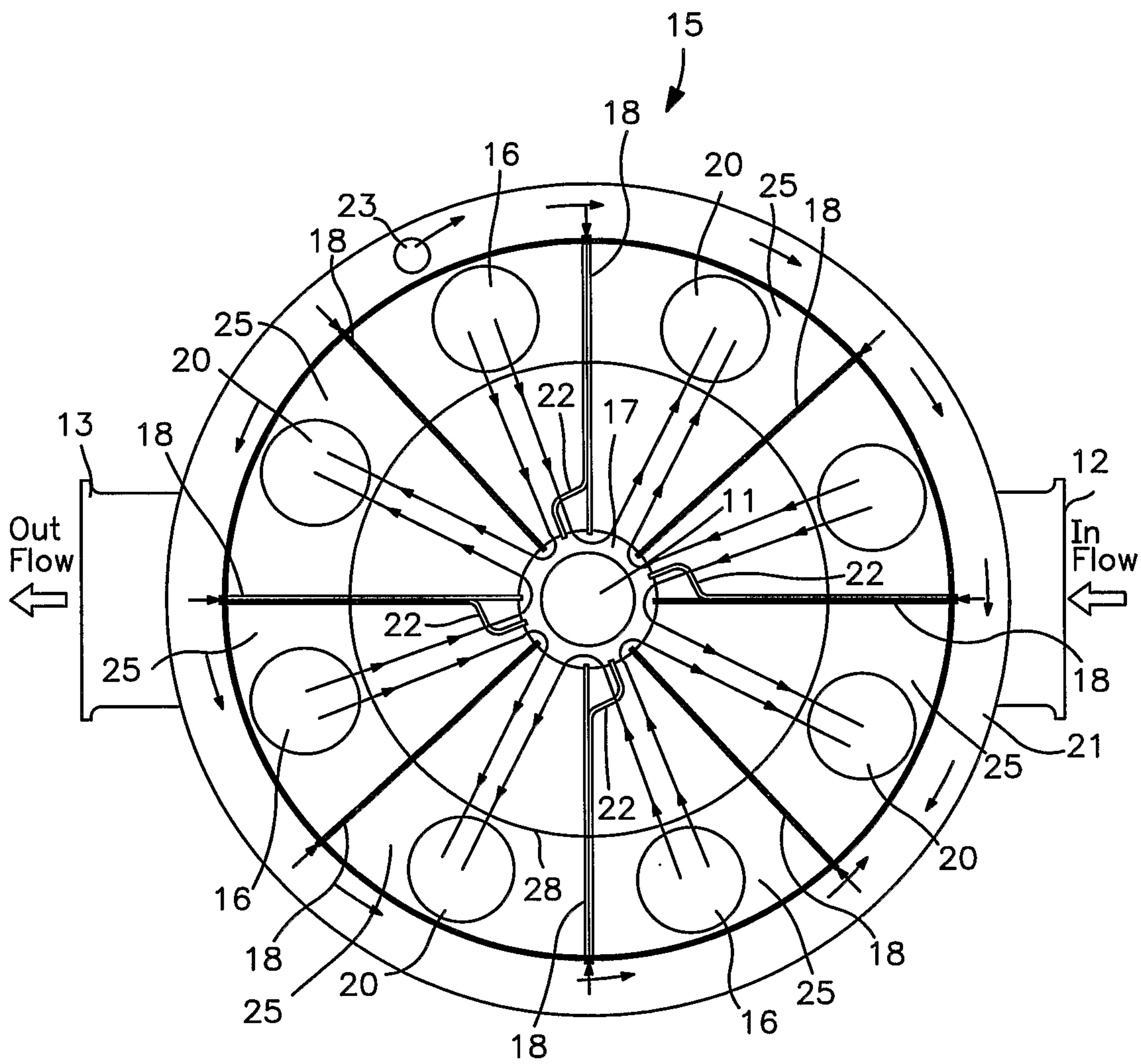


FIG. 1

2/3

